Intel - EPF8636ALC84-3 Datasheet





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Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Obsolete
Number of LABs/CLBs	63
Number of Logic Elements/Cells	504
Total RAM Bits	-
Number of I/O	68
Number of Gates	6000
Voltage - Supply	4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	84-LCC (J-Lead)
Supplier Device Package	84-PLCC (29.31x29.31)
Purchase URL	https://www.e-xfl.com/product-detail/intel/epf8636alc84-3

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FLEX 8000 devices contain an optimized microprocessor interface that permits the microprocessor to configure FLEX 8000 devices serially, in parallel, synchronously, or asynchronously. The interface also enables the microprocessor to treat a FLEX 8000 device as memory and configure the device by writing to a virtual memory location, making it very easy for the designer to create configuration software.

The FLEX 8000 family is supported by Altera's MAX+PLUS II development system, a single, integrated package that offers schematic, text—including the Altera Hardware Description Language (AHDL), VHDL, and Verilog HDL—and waveform design entry, compilation and logic synthesis, simulation and timing analysis, and device programming. The MAX+PLUS II software provides EDIF 2 0 0 and 3 0 0, library of parameterized modules (LPM), VHDL, Verilog HDL, and other interfaces for additional design entry and simulation support from other industrystandard PC- and UNIX workstation-based EDA tools. The MAX+PLUS II software runs on Windows-based PCs and Sun SPARCstation, HP 9000 Series 700/800, and IBM RISC System/6000 workstations.

The MAX+PLUS II software interfaces easily with common gate array EDA tools for synthesis and simulation. For example, the MAX+PLUS II software can generate Verilog HDL files for simulation with tools such as Cadence Verilog-XL. Additionally, the MAX+PLUS II software contains EDA libraries that use device-specific features such as carry chains, which are used for fast counter and arithmetic functions. For instance, the Synopsys Design Compiler library supplied with the MAX+PLUS II development system includes DesignWare functions that are optimized for the FLEX 8000 architecture.



Functional Description For more information on the MAX+PLUS II software, go to the *MAX+PLUS II Programmable Logic Development System & Software Data Sheet*.

The FLEX 8000 architecture incorporates a large matrix of compact building blocks called logic elements (LEs). Each LE contains a 4-input LUT that provides combinatorial logic capability and a programmable register that offers sequential logic capability. The fine-grained structure of the LE provides highly efficient logic implementation.

Eight LEs are grouped together to form a logic array block (LAB). Each FLEX 8000 LAB is an independent structure with common inputs, interconnections, and control signals. The LAB architecture provides a coarse-grained structure for high device performance and easy routing.

Figure 1 shows a block diagram of the FLEX 8000 architecture. Each group of eight LEs is combined into an LAB; LABs are arranged into rows and columns. The I/O pins are supported by I/O elements (IOEs) located at the ends of rows and columns. Each IOE contains a bidirectional I/O buffer and a flipflop that can be used as either an input or output register.



Signal interconnections within FLEX 8000 devices and between device pins are provided by the FastTrack Interconnect, a series of fast, continuous channels that run the entire length and width of the device. IOEs are located at the end of each row (horizontal) and column (vertical) FastTrack Interconnect path.

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The FLEX 8000 architecture provides two dedicated high-speed data paths—carry chains and cascade chains—that connect adjacent LEs without using local interconnect paths. The carry chain supports highspeed counters and adders; the cascade chain implements wide-input functions with minimum delay. Carry and cascade chains connect all LEs in an LAB and all LABs in the same row. Heavy use of carry and cascade chains can reduce routing flexibility. Therefore, the use of carry and cascade chains should be limited to speed-critical portions of a design.

Carry Chain

The carry chain provides a very fast (less than 1 ns) carry-forward function between LEs. The carry-in signal from a lower-order bit moves forward into the higher-order bit via the carry chain, and feeds into both the LUT and the next portion of the carry chain. This feature allows the FLEX 8000 architecture to implement high-speed counters and adders of arbitrary width. The MAX+PLUS II Compiler can create carry chains automatically during design processing; designers can also insert carry chain logic manually during design entry.

Figure 4 shows how an *n*-bit full adder can be implemented in n + 1 LEs with the carry chain. One portion of the LUT generates the sum of two bits using the input signals and the carry-in signal; the sum is routed to the output of the LE. The register is typically bypassed for simple adders, but can be used for an accumulator function. Another portion of the LUT and the carry chain logic generate the carry-out signal, which is routed directly to the carry-in signal of the next-higher-order bit. The final carry-out signal is routed to another LE, where it can be used as a general-purpose signal. In addition to mathematical functions, carry chain logic supports very fast counters and comparators.



Figure 4. FLEX 8000 Carry Chain Operation

Cascade Chain

With the cascade chain, the FLEX 8000 architecture can implement functions that have a very wide fan-in. Adjacent LUTs can be used to compute portions of the function in parallel; the cascade chain serially connects the intermediate values. The cascade chain can use a logical AND or logical OR (via De Morgan's inversion) to connect the outputs of adjacent LEs. Each additional LE provides four more inputs to the effective width of a function, with a delay as low as 0.6 ns per LE.

Normal Mode

The normal mode is suitable for general logic applications and wide decoding functions that can take advantage of a cascade chain. In normal mode, four data inputs from the LAB local interconnect and the carry-in signal are the inputs to a 4-input LUT. Using a configurable SRAM bit, the MAX+PLUS II Compiler automatically selects the carry-in or the DATA3 signal as an input. The LUT output can be combined with the cascade-in signal to form a cascade chain through the cascade-out signal. The LE-Out signal—the data output of the LE—is either the combinatorial output of the LUT and cascade chain, or the data output (Q) of the programmable register.

Arithmetic Mode

The arithmetic mode offers two 3-input LUTs that are ideal for implementing adders, accumulators, and comparators. One LUT provides a 3-bit function; the other generates a carry bit. As shown in Figure 6, the first LUT uses the carry-in signal and two data inputs from the LAB local interconnect to generate a combinatorial or registered output. For example, in an adder, this output is the sum of three bits: a, b, and the carry-in. The second LUT uses the same three signals to generate a carry-out signal, thereby creating a carry chain. The arithmetic mode also supports a cascade chain.

Up/Down Counter Mode

The up/down counter mode offers counter enable, synchronous up/down control, and data loading options. These control signals are generated by the data inputs from the LAB local interconnect, the carry-in signal, and output feedback from the programmable register. Two 3-input LUTs are used: one generates the counter data, and the other generates the fast carry bit. A 2-to-1 multiplexer provides synchronous loading. Data can also be loaded asynchronously with the clear and preset register control signals, without using the LUT resources.

Clearable Counter Mode

The clearable counter mode is similar to the up/down counter mode, but supports a synchronous clear instead of the up/down control; the clear function is substituted for the cascade-in signal in the up/down counter mode. Two 3-input LUTs are used: one generates the counter data, and the other generates the fast carry bit. Synchronous loading is provided by a 2-to-1 multiplexer, and the output of this multiplexer is ANDed with a synchronous clear.

Figure 7. FLEX 8000 LE Asynchronous Clear & Preset Modes



Asynchronous Load with Clear



Asynchronous Load with Preset



Asynchronous Load without Clear or Preset



Asynchronous Clear

A register is cleared by one of the two LABCTRL signals. When the CLRn port receives a low signal, the register is set to zero.

Asynchronous Preset

An asynchronous preset is implemented as either an asynchronous load or an asynchronous clear. If DATA3 is tied to VCC, asserting LABCTRL1 asynchronously loads a 1 into the register. Alternatively, the MAX+PLUS II software can provide preset control by using the clear and inverting the input and output of the register. Inversion control is available for the inputs to both LEs and IOEs. Therefore, if a register is preset by only one of the two LABCTRL signals, the DATA3 input is not needed and can be used for one of the LE operating modes.

Asynchronous Clear & Preset

When implementing asynchronous clear and preset, LABCTRL1 controls the preset and LABCTRL2 controls the clear. The DATA3 input is tied to VCC; therefore, asserting LABCTRL1 asynchronously loads a 1 into the register, effectively presetting the register. Asserting LABCTRL2 clears the register.

Asynchronous Load with Clear

When implementing an asynchronous load with the clear, LABCTRL1 implements the asynchronous load of DATA3 by controlling the register preset and clear. LABCTRL2 implements the clear by controlling the register clear.

Asynchronous Load with Preset

When implementing an asynchronous load in conjunction with a preset, the MAX+PLUS II software provides preset control by using the clear and inverting the input and output of the register. Asserting LABCTRL2 clears the register, while asserting LABCTRL1 loads the register. The MAX+PLUS II software inverts the signal that drives the DATA3 signal to account for the inversion of the register's output.

Asynchronous Load without Clear or Preset

When implementing an asynchronous load without the clear or preset, LABCTRL1 implements the asynchronous load of DATA3 by controlling the register preset and clear.

FastTrack Interconnect

In the FLEX 8000 architecture, connections between LEs and device I/O pins are provided by the FastTrack Interconnect, a series of continuous horizontal (row) and vertical (column) routing channels that traverse the entire FLEX 8000 device. This device-wide routing structure provides predictable performance even in complex designs. In contrast, the segmented routing structure in FPGAs requires switch matrices to connect a variable number of routing paths, which increases the delays between logic resources and reduces performance.

The LABs within FLEX 8000 devices are arranged into a matrix of columns and rows. Each row of LABs has a dedicated row interconnect that routes signals both into and out of the LABs in the row. The row interconnect can then drive I/O pins or feed other LABs in the device. Figure 8 shows how an LE drives the row and column interconnect.

Figure 8. FLEX 8000 LAB Connections to Row & Column Interconnect





Each LE in an LAB can drive up to two separate column interconnect channels. Therefore, all 16 available column channels can be driven by the LAB. The column channels run vertically across the entire device, and share access to LABs in the same column but in different rows. The MAX+PLUS II Compiler chooses which LEs must be connected to a column channel. A row interconnect channel can be fed by the output of the LE or by two column channels. These three signals feed a multiplexer that connects to a specific row channel. Each LE is connected to one 3-to-1 multiplexer. In an LAB, the multiplexers provide all 16 column channels with access to 8 row channels.

Each column of LABs has a dedicated column interconnect that routes signals out of the LABs into the column. The column interconnect can then drive I/O pins or feed into the row interconnect to route the signals to other LABs in the device. A signal from the column interconnect, which can be either the output of an LE or an input from an I/O pin, must transfer to the row interconnect before it can enter an LAB. Table 4 summarizes the FastTrack Interconnect resources available in each FLEX 8000 device.

Table 4. FLE	Table 4. FLEX 8000 FastTrack Interconnect Resources						
Device	Rows	Channels per Row	Columns	Channels per Column			
EPF8282A EPF8282AV	2	168	13	16			
EPF8452A	2	168	21	16			
EPF8636A	3	168	21	16			
EPF8820A	4	168	21	16			
EPF81188A	6	168	21	16			
EPF81500A	6	216	27	16			

Figure 9 shows the interconnection of four adjacent LABs, with row, column, and local interconnects, as well as the associated cascade and carry chains.

Figure 9. FLEX 8000 Device Interconnect Resources

Each LAB is named according to its physical row (A, B, C, etc.) and column (1, 2, 3, etc.) position within the device.



I/O Element

An IOE contains a bidirectional I/O buffer and a register that can be used either as an input register for external data that requires a fast setup time, or as an output register for data that requires fast clock-to-output performance. IOEs can be used as input, output, or bidirectional pins. The MAX+PLUS II Compiler uses the programmable inversion option to automatically invert signals from the row and column interconnect where appropriate. Figure 10 shows the IOE block diagram.

MultiVolt I/O Interface

The FLEX 8000 device architecture supports the MultiVolt I/O interface feature, which allows EPF81500A, EPF81188A, EPF8820A, and EPF8636A devices to interface with systems with differing supply voltages. These devices in all packages—except for EPF8636A devices in 84-pin PLCC packages—can be set for 3.3-V or 5.0-V I/O pin operation. These devices have one set of V_{CC} pins for internal operation and input buffers (VCCINT), and another set for I/O output drivers (VCCIO).

The VCCINT pins must always be connected to a 5.0-V power supply. With a 5.0-V V_{CCINT} level, input voltages are at TTL levels and are therefore compatible with 3.3-V and 5.0-V inputs.

The VCCIO pins can be connected to either a 3.3-V or 5.0-V power supply, depending on the output requirements. When the VCCIO pins are connected to a 5.0-V power supply, the output levels are compatible with 5.0-V systems. When the VCCIO pins are connected to a 3.3-V power supply, the output high is at 3.3 V and is therefore compatible with 3.3-V or 5.0-V systems. Devices operating with V_{CCIO} levels lower than 4.75 V incur a nominally greater timing delay of t_{OD2} instead of t_{OD1} . See Table 8 on page 26.

IEEE Std. 1149.1 (JTAG) Boundary-Scan Support

The EPF8282A, EPF8282AV, EPF8636A, EPF8820A, and EPF81500A devices provide JTAG BST circuitry. FLEX 8000 devices with JTAG circuitry support the JTAG instructions shown in Table 6.

Table 6. EPF8282A,	EPF8282AV, EPF8636A, EPF8820A & EPF81500A JTAG Instructions
JTAG Instruction	Description
SAMPLE/PRELOAD	Allows a snapshot of the signals at the device pins to be captured and examined during normal device operation, and permits an initial data pattern to be output at the device pins.
EXTEST	Allows the external circuitry and board-level interconnections to be tested by forcing a test pattern at the output pins and capturing test results at the input pins.
BYPASS	Places the 1-bit bypass register between the TDI and TDO pins, which allows the BST data to pass synchronously through the selected device to adjacent devices during normal device operation.

Symbol	Parameter	EPF8	282AV 636A	Unit
		Min	Мах	
t _{JCP}	TCK clock period	100		ns
t _{JCH}	TCK clock high time	50		ns
t _{JCL}	TCK clock low time	50		ns
t _{JPSU}	JTAG port setup time	20		ns
t _{JPH}	JTAG port hold time	45		ns
t _{JPCO}	JTAG port clock to output		25	ns
t _{JPZX}	JTAG port high-impedance to valid output		25	ns
t _{JPXZ}	JTAG port valid output to high-impedance		25	ns
t _{JSSU}	Capture register setup time	20		ns
t _{JSH}	Capture register hold time	45		ns
t _{JSCO}	Update register clock to output		35	ns
t _{JSZX}	Update register high-impedance to valid output		35	ns
t _{JSXZ}	Update register valid output to high-impedance		35	ns

For detailed information on JTAG operation in FLEX 8000 devices, refer to *Application Note 39 (IEEE 1149.1 (JTAG) Boundary-Scan Testing in Altera Devices)*.

Generic Testing

Each FLEX 8000 device is functionally tested and specified by Altera. Complete testing of each configurable SRAM bit and all logic functionality ensures 100% configuration yield. AC test measurements for FLEX 8000 devices are made under conditions equivalent to those shown in Figure 15. Designers can use multiple test patterns to configure devices during all stages of the production flow.

Table 17. F	ELEX 8000 Internal Timing Parameters Note (1)
Symbol	Parameter
t _{IOD}	IOE register data delay
t _{IOC}	IOE register control signal delay
t _{IOE}	Output enable delay
t _{IOCO}	IOE register clock-to-output delay
t _{IOCOMB}	IOE combinatorial delay
t _{IOSU}	IOE register setup time before clock; IOE register recovery time after asynchronous clear
t _{IOH}	IOE register hold time after clock
t _{IOCLR}	IOE register clear delay
t _{IN}	Input pad and buffer delay
t _{OD1}	Output buffer and pad delay, slow slew rate = off, $V_{CCIO} = 5.0 \text{ V C1} = 35 \text{ pF}$ (2)
t _{OD2}	Output buffer and pad delay, slow slew rate = off, V_{CCIO} = 3.3 V C1 = 35 pF (2)
t _{OD3}	Output buffer and pad delay, slow slew rate = on, C1 = 35 pF (3)
t _{XZ}	Output buffer disable delay, C1 = 5 pF
t _{ZX1}	Output buffer enable delay, slow slew rate = off, V_{CCIO} = 5.0 V, C1 = 35 pF (2)
t _{ZX2}	Output buffer enable delay, slow slew rate = off, V_{CCIO} = 3.3 V, C1 = 35 pF (2)
t _{ZX3}	Output buffer enable delay, slow slew rate = on, C1 = 35 pF (3)

Symbol	Parameter
t _{LUT}	LUT delay for data-in
t _{CLUT}	LUT delay for carry-in
t _{RLUT}	LUT delay for LE register feedback
t _{GATE}	Cascade gate delay
t _{CASC}	Cascade chain routing delay
t _{CICO}	Carry-in to carry-out delay
t _{CGEN}	Data-in to carry-out delay
t _{CGENR}	LE register feedback to carry-out delay
t _C	LE register control signal delay
t _{CH}	LE register clock high time
t _{CL}	LE register clock low time
t _{CO}	LE register clock-to-output delay
t _{COMB}	Combinatorial delay
t _{SU}	LE register setup time before clock; LE register recovery time after asynchronous preset, clear, or load
t _H	LE register hold time after clock
t _{PRE}	LE register preset delay
t _{CLR}	LE register clear delay

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Source	Destination	Total Delay	
LE-Out	LE in same LAB	t _{LOCAL}	
LE-Out	LE in same row, different LAB	$t_{ROW} + t_{LOCAL}$	
LE-Out	LE in different row	$t_{COL} + t_{ROW} + t_{LOCAL}$	
LE-Out	IOE on column	t _{COL}	
LE-Out	IOE on row	t _{ROW}	
IOE on row	LE in same row	$t_{ROW} + t_{LOCAL}$	
IOE on column	Any LE	$t_{COL} + t_{ROW} + t_{LOCAL}$	

Tables 22 through 49 show the FLEX 8000 internal and external timing parameters.

Symbol	Speed Grade						
	A-2		A-3		A-4		1
	Min	Max	Min	Мах	Min	Max	
t _{IOD}		0.7		0.8		0.9	ns
t _{IOC}		1.7		1.8		1.9	ns
t _{IOE}		1.7		1.8		1.9	ns
t _{IOCO}		1.0		1.0		1.0	ns
t _{IOCOMB}		0.3		0.2		0.1	ns
t _{IOSU}	1.4		1.6		1.8		ns
t _{IOH}	0.0		0.0		0.0		ns
t _{IOCLR}		1.2		1.2		1.2	ns
t _{IN}		1.5		1.6		1.7	ns
t _{OD1}		1.1		1.4		1.7	ns
t _{OD2}		-		-		-	ns
t _{OD3}		4.6		4.9		5.2	ns
t _{XZ}		1.4		1.6		1.8	ns
t _{ZX1}		1.4		1.6		1.8	ns
t _{ZX2}		-		-		-	ns
t _{ZX3}		4.9		5.1		5.3	ns

Symbol	Speed Grade						
	A-2		A-3		A-4		1
	Min	Max	Min	Мах	Min	Мах	
t _{LUT}		2.0		2.5		3.2	ns
t _{CLUT}		0.0		0.0		0.0	ns
t _{RLUT}		0.9		1.1		1.5	ns
t _{GATE}		0.0		0.0		0.0	ns
t _{CASC}		0.6		0.7		0.9	ns
t _{CICO}		0.4		0.5		0.6	ns
t _{CGEN}		0.4		0.5		0.7	ns
t _{CGENR}		0.9		1.1		1.5	ns
t _C		1.6		2.0		2.5	ns
t _{CH}	4.0		4.0		4.0		ns
t _{CL}	4.0		4.0		4.0		ns
t _{CO}		0.4		0.5		0.6	ns
t _{COMB}		0.4		0.5		0.6	ns
t _{SU}	0.8		1.1		1.2		ns
t _H	0.9		1.1		1.5		ns
t _{PRE}		0.6		0.7		0.8	ns
t _{CLR}		0.6		0.7		0.8	ns

Table 25. EPF8282A External Timing Parameters

Symbol		Speed Grade						
	A	-2	A	-3	A-	4		
	Min	Max	Min	Max	Min	Мах		
t _{DRR}		15.8		19.8		24.8	ns	
t _{ODH}	1.0		1.0		1.0		ns	

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Symbol	Speed Grade						
	A	-3	A				
	Min	Max	Min	Мах			
t _{IOD}		0.9		2.2	ns		
tioc		1.9		2.0	ns		
t _{IOE}		1.9		2.0	ns		
tioco		1.0		2.0	ns		
tiocoмв		0.1		0.0	ns		
tiosu	1.8		2.8		ns		
^t іон	0.0		0.2		ns		
tioclr		1.2		2.3	ns		
t _{IN}		1.7		3.4	ns		
t _{OD1}		1.7		4.1	ns		
t _{OD2}		-		-	ns		
tod3		5.2		7.1	ns		
t _{XZ}		1.8		4.3	ns		
ZX1		1.8		4.3	ns		
ZX2		_		-	ns		
t _{ZX3}		5.3		8.3	ns		

Symbol 		Speed Grade						
	A	-3	A	-4				
	Min	Мах	Min	Max				
t _{LABCASC}		0.4		1.3	ns			
t _{LABCARRY}		0.4		0.8	ns			
t _{LOCAL}		0.8		1.5	ns			
t _{ROW}		4.2		6.3	ns			
t _{COL}		2.5		3.8	ns			
t _{DIN_C}		5.5		8.0	ns			
t _{DIN_D}		7.2		10.8	ns			
t _{DIN IO}		5.5		9.0	ns			

Symbol	Speed Grade								
	A-2		A-3		A-4		1		
	Min	Max	Min	Max	Min	Max	-		
t _{LUT}		2.0		2.3		3.0	ns		
t _{CLUT}		0.0		0.2		0.1	ns		
t _{RLUT}		0.9		1.6		1.6	ns		
t _{GATE}		0.0		0.0		0.0	ns		
t _{CASC}		0.6		0.7		0.9	ns		
t _{CICO}		0.4		0.5		0.6	ns		
t _{CGEN}		0.4		0.9		0.8	ns		
t _{CGENR}		0.9		1.4		1.5	ns		
t _C		1.6		1.8		2.4	ns		
t _{CH}	4.0		4.0		4.0		ns		
t _{CL}	4.0		4.0		4.0		ns		
t _{CO}		0.4		0.5		0.6	ns		
t _{COMB}		0.4		0.5		0.6	ns		
t _{SU}	0.8		1.0		1.1		ns		
t _H	0.9		1.1		1.4		ns		
t _{PRE}		0.6		0.7		0.8	ns		
t _{CLR}		0.6		0.7		0.8	ns		

Table 33. EPF8452A External Timing Parameters

Symbol	Speed Grade							
	A	-2	A	-3	A	-4		
	Min	Max	Min	Max	Min	Мах		
t _{DRR}		16.0		20.0		25.0	ns	
t _{oDH}	1.0		1.0		1.0		ns	

Symbol	Speed Grade							
	A-2		A-3		A-4			
	Min	Max	Min	Max	Min	Max	-	
t _{LUT}		2.0		2.5		3.2	ns	
t _{CLUT}		0.0		0.0		0.0	ns	
t _{RLUT}		0.9		1.1		1.5	ns	
t _{GATE}		0.0		0.0		0.0	ns	
t _{CASC}		0.6		0.7		0.9	ns	
t _{CICO}		0.4		0.5		0.6	ns	
t _{CGEN}		0.4		0.5		0.7	ns	
t _{CGENR}		0.9		1.1		1.5	ns	
t _C		1.6		2.0		2.5	ns	
t _{CH}	4.0		4.0		4.0		ns	
t _{CL}	4.0		4.0		4.0		ns	
t _{CO}		0.4		0.5		0.6	ns	
t _{COMB}		0.4		0.5		0.6	ns	
t _{SU}	0.8		1.1		1.2		ns	
t _H	0.9		1.1		1.5		ns	
t _{PRE}		0.6		0.7		0.8	ns	
t _{CLR}		0.6		0.7		0.8	ns	

Symbol		Speed Grade							
	A	A-2		A-3		-4			
	Min	Max	Min	Max	Min	Мах			
t _{DRR}		16.1		20.1		25.1	ns		
t _{oDH}	1.0		1.0		1.0		ns		

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Table 52. FLEX	Table 52. FLEX 8000 84-, 100-, 144- & 160-Pin Package Pin-Outs (Part 3 of 3)									
Pin Name	84-Pin PLCC EPF8282A	84-Pin PLCC EPF8452A EPF8636A	100-Pin TQFP EPF8282A EPF8282AV	100-Pin TQFP EPF8452A	144-Pin TQFP EPF8820A	160-Pin PGA EPF8452A	160-Pin PQFP EPF8820A (1)			
GND	5, 26, 47, 68	5, 26, 47, 68	2, 13, 30, 44, 52, 63, 80, 94	19, 44, 69, 94	7, 17, 27, 39, 54, 80, 81, 100,101, 128, 142	C12, D4, D7, D9, D13, G4, G13, H3, H12, J4, J13, L1, M3, M8, M12, M15, N4	12, 13, 34, 35, 51, 63, 75, 80, 83, 93, 103, 115, 126, 131, 143, 155			
No Connect (N.C.)	-	-	-	2, 6, 13, 30, 37, 42, 43, 50, 52, 56, 63, 80, 87, 92, 93, 99	-	-	-			
Total User I/O Pins (9)	64	64	74	64	108	116	116			

Pin Name	160-Pin PQFP EPF8452A	160-Pin PQFP EPF8636A	192-Pin PGA EPF8636A EPF8820A	208-Pin PQFP EPF8636A (1)	208-Pin PQFP EPF8820A (1)	208-Pin PQFP EPF81188A <i>(1)</i>
nSP (2)	120	1	R15	207	207	5
MSEL0 (2)	117	3	T15	4	4	3 21
MSELU (2) MSEL1 (2)	84	38	T3	49	49	33
nSTATUS (2)	37	83	B3	108	108	124
. ,	40	81	C3	103	103	107
nCONFIG (2) DCLK (2)	1	120	C15	158	158	154
	4					134
CONF_DONE (2)	4	118	B15	153	153	138
nWS	30	89	C5	114	114	118
nRS	71	50	B5	66	116	121
RDCLK	73	48	C11	64	137	137
nCS	29	91	B13	116	145	142
CS	27	93	A16	118	148	144
RDYnBUSY	125	155	A8	201	127	128
CLKUSR	76	44	A10	59	134	134
ADD17	78	43	R5	57	43	46
ADD16	91	33	U3	43	42	45
ADD15	92	31	T5	41	41	44
ADD14	94	29	U4	39	40	39
ADD13	95	27	R6	37	39	37
ADD12	96	24	Т6	31	35	36
ADD11	97	23	R7	30	33	31
ADD10	98	22	T7	29	31	30
ADD9	99	21	Т8	28	29	29
ADD8	101	20	U9	24	25	26
ADD7	102	19	U10	23	23	25
ADD6	103	18	U11	22	21	24
ADD5	104	17	U12	21	19	18
ADD4	105	13	R12	14	14	17
ADD3	106	11	U14	12	13	16
ADD2	109	9	U15	10	11	10
ADD1	110	7	R13	8	10	9
ADD0	123	157	U16	203	9	8
DATA7	144	137	H17	178	178	177
DATA6	150	132	G17	172	176	175
DATA5	152	129	F17	169	174	172

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